

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant : Swee-Ann Teo et al. Art Unit : Unknown  
Serial No. : Unassigned Examiner : Unknown  
Filed :  
Title : SIGMA DELTA MODULATED PHASE LOCK LOOP WITH PHASE  
INTERPOLATION

Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

INFORMATION DISCLOSURE STATEMENT

Applicant submits the references listed on the attached form PTO-1449.

This statement is being filed with the application. Accordingly, only copies of foreign patent documents and non-patent literature are enclosed. Please apply any charges or credits to Deposit Account No. 06-1050.

Respectfully submitted,



Kelvin M. Vivian  
Reg. No. 53,727

Eric B. Janofsky  
General Patent Counsel  
Marvell Semiconductor, Inc.  
700 First Street, Mail Stop 509  
Sunnyvale, CA 94089  
Customer No. 23624

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Substitute Form PTO-1449 (Modified)		U.S. Department of Commerce Patent and Trademark Office		Attorney's Docket No. <b>MP0359</b>	Application No. <b>Unassigned</b>
<b>Information Disclosure Statement by Applicant</b> (Use several sheets if necessary)  (37 CFR §1.98(b))		Applicant <b>Swee-Ann Teo et al.</b>			
		Filing Date <b>Herewith</b>	Group Art Unit <b>Unknown</b>		

<b>U.S. Patent Documents</b>							
Examiner Initial	Desig. ID	Document Number	Publication / Issue Date	Patentee	Class	Subclass	Filing Date If Appropriate
	AA	6,031,426	02/29/2000	Yechuri			
	AB	6,420,940	07/16/2002	Minnis et al.			
	AC	6,509,773	01/21/2003	Buchwald et al.			
	AD	6,542,013	04/01/2003	Volk et al.			
	AE	US/2002/0163389A1	11/07/2002	Jun			
	AF	US/2003/0108143A1	06/12/2003	Han et al.			
	AG						
	AH						
	AI						
	AJ						
	AK						

<b>Foreign Patent Documents or Published Foreign Patent Applications</b>							
Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Translation
							Yes No
	AL	WO 00002316 A1	01/13/2000	WIPO			
	AM						
	AN						
	AO						
	AP						

<b>Other Documents (include Author, Title, Date, and Place of Publication)</b>		
Examiner Initial	Desig. ID	Document
	AQ	
	AR	
	AS	
	AT	

Examiner Signature	Date Considered
EXAMINER: Initials citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.	